

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/649,260 | | Applicant(s)/Patent Under Reexamination DABAK ET AL. | |
| | Examiner Man Phan | | Art Unit 2619 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-6,714,511 | 03-2004 | Sudo et al. | 370/208 |
| * | B | US-7,336,598 | 02-2008 | Kakura, Yoshikazu | 370/208 |
| * | C | US-7,106,781 | 09-2006 | Agee et al. | 375/141 |
| * | D | US-2001/0040912 | 11-2001 | Gibbons et al. | 375/133 |
| * | E | US-7,266,162 | 09-2007 | Jiang, Hong | 375/326 |
| * | F | US-7,184,713 | 02-2007 | Kadous et al. | 455/67.13 |
| * | G | US-2003/0095508 | 05-2003 | Kadous et al. | 370/252 |
| * | H | US-2005/0259566 | 11-2005 | Chung et al. | 370/204 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.